

**Notice of References Cited**

Application/Control No.

09/758,963

Applicant(s)/Patent Under

Reexamination  
YOSHIDA ET AL.

Examiner

Dung (Michael) T Nguyen

Art Unit

2828

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	A	US-5,036,521	07-1991	Hatakoshi et al.	372/46
X	B	US-5,993,073 A	11-1999	Hamakawa et al.	385/88
X	C	US-6,174,748 B1	01-2001	Jeon et al.	438/31
X	D	US-6,249,534 B1	06-2001	Itoh et al.	372/49
X	E	US-6,233,264 B1	05-2001	Sato, Shunichi	372/45
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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